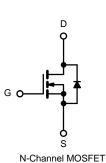


NCE8050AK-VB Datasheet N-Channel 80 V (D-S) MOSFET

PRODUCT SUMMARY				
$R_{DS(on)}$ (Ω) Max.	I _D (A)	Q _g (Typ.)		
0.0050 at $V_{GS} = 10 V$	75 ^a			
0.0070 at V _{GS} = 6.0 V	65 ^a	17.1 nC		
0.0087 at V _{GS} = 5.0 V	54			
	R _{DS(on)} (Ω) Max. 0.0050 at V _{GS} = 10 V 0.0070 at V _{GS} = 6.0 V	$\mathbf{R}_{DS(on)}$ (Ω) Max. \mathbf{I}_{D} (A) 0.0050 at V_{GS} = 10 V 75 ^a 0.0070 at V_{GS} = 6.0 V 65 ^a		

TO-252



Top View

FEATURES

- Trench Power MOSFET
- 100 % $\rm R_g$ and UIS Tested

APPLICATIONS

- Primary Side Switching
- Synchronous Rectification
- DC/AC Inverters
- LED Backlighting



ABSOLUTE MAXIMUM RATINGS (TA	∖ = 25 °C, unless	otherwise note	d)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	80	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		75 ^a		
Continuous Drain Current (T 150 °C)	T _C = 70 °C		62.7		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	28.6 ^{b, c}		
	T _A = 70 °C		24.9 ^{b, c}	A	
Pulsed Drain Current (t = 100 µs)	I _{DM}	150			
Continuous Source Drain Diada Current	T _C = 25 °C		75a]	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	4.5 ^{b, c}]	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	30]	
Single Pulse Avalanche Energy	L = 0.1 MH	E _{AS}	45	mJ	
	T _C = 25 °C		62.5		
Maximum Power Dissipation	T _C = 70 °C		40	w	
	T _A = 25 °C	P _D	5 ^{b, c}	vv	
	T _A = 70 °C		3.2 ^{b, c}]	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.5	2.0	C/W

Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

- d. The TO-220 is a leadless package. The end of the lead terminal is exposed
- copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 70 $^{\circ}\text{C/W}.$

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V, I_{D} = 250 \mu A$	80			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$			37			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μΑ		- 6.1		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th})	V _{DS} = V _{GS} , I _D = 250 μA	2.5		4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	30			А	
		V _{GS} = 10 V, I _D = 20 A		0.0050			
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 6 V, I _D = 15 A		0.0070		Ω	
		$V_{GS} = 5.0 \text{ V}, \text{ I}_{D} = 10 \text{ A}$		0.0087		1	
Forward Transconductance ^a	g _{fs}	V _{DS} = 10 V, I _D = 20 A		60		S	
Dynamic ^b						•	
Input Capacitance	C _{iss}			1855			
Output Capacitance	C _{oss}	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		950		pF	
Reverse Transfer Capacitance	C _{rss}			76			
Total Gate Charge	Qg	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		35.5	54		
		$V_{DS} = 40 \text{ V}, V_{GS} = 6 \text{ V}, I_D = 10 \text{ A}$	22 3		33	1	
	-			17.1	26		
Gate-Source Charge	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		5.3		– nC	
Gate-Drain Charge	Q _{gd}			7.3			
Output Charge	Q _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$		57	86	1	
Gate Resistance	R _g	f = 1 MHz	0.5	1.3	2	Ω	
Turn-On Delay Time	t _{d(on)}			12	24	1	
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{\text{I}} = 4 \Omega$		8	16		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10$ Å, $V_{GEN} = 10$ V, $R_g = 1$ Ω		32	64	-	
Fall Time	t _f			7	14		
Turn-On Delay Time	t _{d(on)}			14	28	ns	
Rise Time	t _r	$V_{DD} = 40 \text{ V}, \text{ R}_{\text{I}} = 4 \Omega$		11	22	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{\text{GEN}} = 6.0 \text{ V}, R_g = 1 \Omega$		30	60		
Fall Time	t _f			8	16	1	
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			75		
Pulse Diode Forward Current (t = 100 µs)	I _{SM}				150	A	
Body Diode Voltage	V _{SD}	I _S = 5 A		0.76	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			38	75	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			36	70	nC	
Reverse Recovery Fall Time	t _a	I _F = 10 A, dl/dt = 100 A/μs, T _J = 25 °C		19			
Reverse Recovery Rise Time	t _b			19		ns	

Notes

a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Bsemi



= - 55 °C

°C

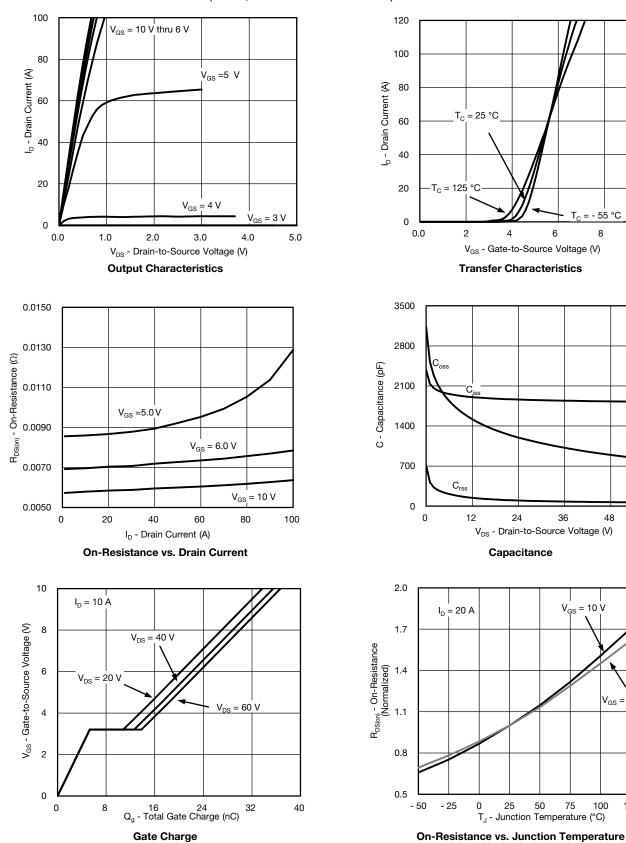
Capacitance

T_J - Junction Temperature (°C)

 $V_{GS} = 10 V$

V_{DS} - Drain-to-Source Voltage (V)

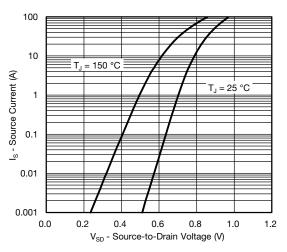
V_{GS} = 4.5 V



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

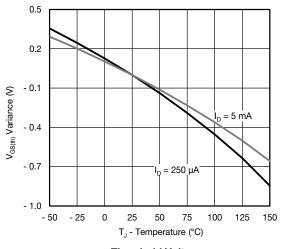




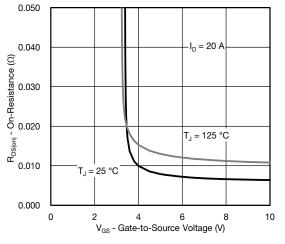


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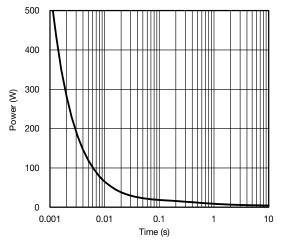




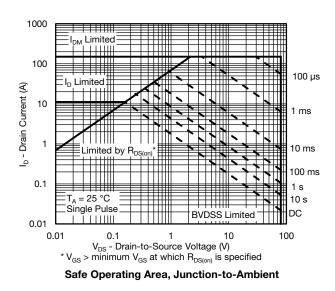




On-Resistance vs. Gate-to-Source Voltage

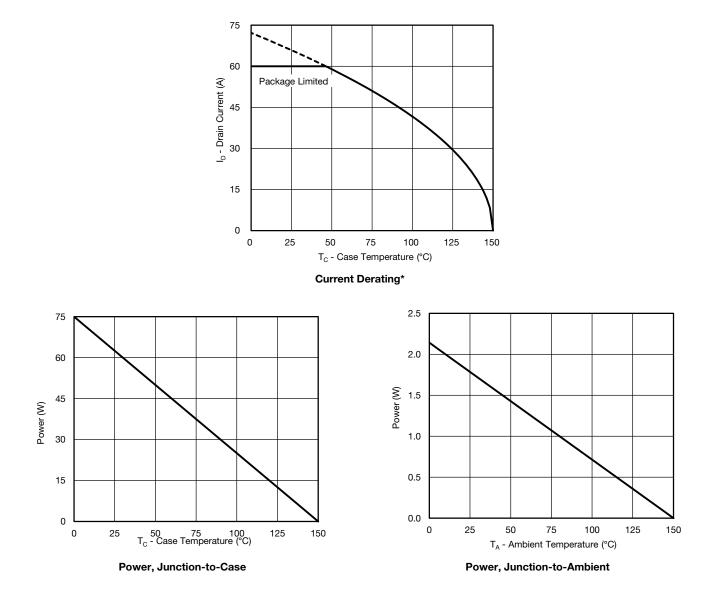


Single Pulse Power, Junction-to-Ambient





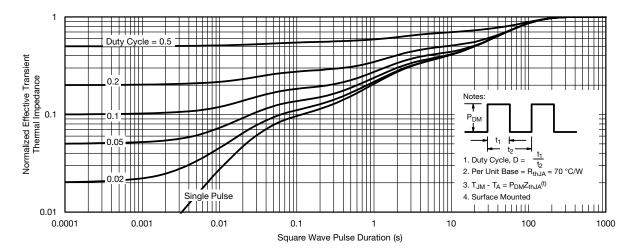
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



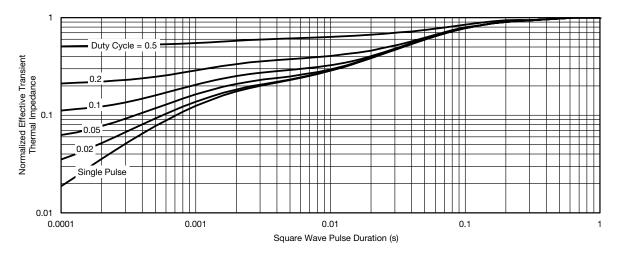
* The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



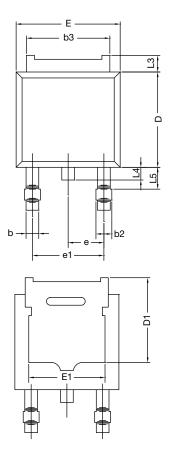


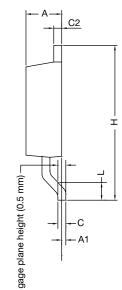


Normalized Thermal Transient Impedance, Junction-to-Case



TO-252AA CASE OUTLINE





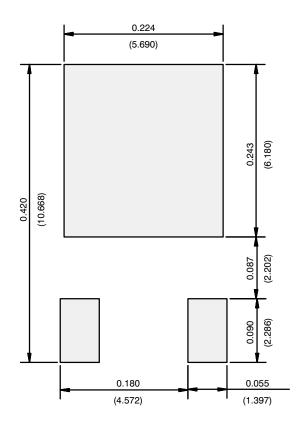
	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	2.18	2.38	0.086	0.094
A1	-	0.127	-	0.005
b	0.64	0.88	0.025	0.035
b2	0.76	1.14	0.030	0.045
b3	4.95	5.46	0.195	0.215
С	0.46	0.61	0.018	0.024
C2	0.46	0.89	0.018	0.035
D	5.97	6.22	0.235	0.245
D1	5.21	-	0.205	-
E	6.35	6.73	0.250	0.265
E1	4.32	-	0.170	-
Н	9.40	10.41	0.370	0.410
е	2.28	BSC	0.090	BSC
e1	4.56 BSC		0.180 BSC	
L	1.40	1.78	0.055	0.070
L3	0.89	1.27	0.035	0.050
L4	-	1.02	-	0.040
L5	1.14	1.52	0.045	0.060
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347				

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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